Search Notes		

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
09/539,872	BALAKRISHNAN ET A	L
Examiner	Art Unit	
Kimbinh T. Nguyen	2628	

	SEARCHED		
Class	Subclass	Date	Examiner
264	409	8/22/2006	KN
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
WEST: text search	8/22/2006	KN
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